



FDP33N25 / FDPF33N25T 250V N-Channel MOSFET

Features

- 33A, 250V, $R_{DS(on)}$ = 0.094 Ω @V_{GS} = 10 V Low gate charge (typical 36.8 nC)
- Low Crss (typical 39 pF)
- Fast switching
- · Improved dv/dt capability



Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



Absolute Maximum Ratings

Symbol	Parameter		FDP33N25	FDPF33N25T	Unit	
V _{DSS}	Drain-Source Voltage		250		V	
I _D	Drain Current	Current - Continuous ($T_C = 25$ °C) - Continuous ($T_C = 100$ °C)		33 33* 20.4 20.4*		A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	132	132*	А
V _{GSS}	Gate-Source voltage		± 30		V	
E _{AS}	Single Pulsed Avalanche Energy (N		(Note 2)	918		mJ
I _{AR}	Avalanche Current		(Note 1)	33		А
E _{AR}	Repetitive Avalanche Energy		(Note 1)	23.5		mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5		V/ns
P_{D}	Power Dissipation	(T _C = 25°C) - Derate above 25°C		235 1.89	37 0.29	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		°C	

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP33N25	FDPF33N25T	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.53	3.4	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP33N25	FDP33N25	TO-220	-	-	50
FDPF33N25T	FDPF33N25T	TO-220F	-	-	50

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Off Charac	teristics			•		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V$, $I_D = 250\mu A$, $T_J = 25^{\circ}C$	250			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		0.25		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 250V, V_{GS} = 0V$ $V_{DS} = 200V, T_C = 125^{\circ}C$	 		1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V$, $V_{DS} = 0V$			-100	nA
On Charac	teristics				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 16.5A		0.077	0.094	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 16.5A$ (Note 4)		26.6		S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$,		1640	2135	pF
C _{oss}	Output Capacitance	f = 1.0MHz		330	430	pF
C _{rss}	Reverse Transfer Capacitance			39	59	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	25 . 5		35	80	ns
t _r	Turn-On Rise Time	$R_{G} = 25\Omega$		230	470	ns
t _{d(off)}	Turn-Off Delay Time			75	160	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		120	250	ns
Q_g	Total Gate Charge	$V_{DS} = 200V, I_{D} = 33A$		36.8	48	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10V$		10		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		17		nC
Drain-Sour	ce Diode Characteristics and Maximun	n Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				33	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				132	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 33A			1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{S} = 33A$		220		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s $ (Note 4)		1.71		μС

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1.35mH, I_{AS} = 33A, V_{DD} = 50V, R_{G} = 25 $\!\Omega$, Starting T_{J} = 25°C
- 3. $I_{SD} \leq$ 33A, di/dt \leq 200A/ μ s, $V_{DD} \leq$ BV $_{DSS}$, Starting T_J = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

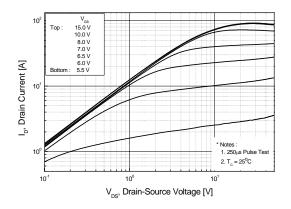


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

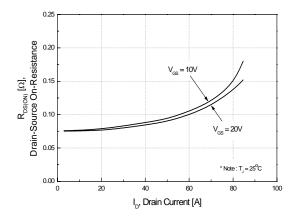


Figure 5. Capacitance Characteristics

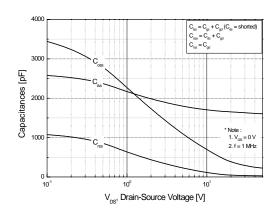


Figure 2. Transfer Characteristics

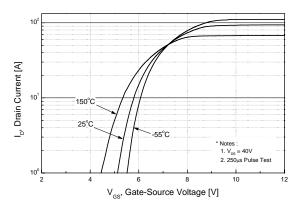


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

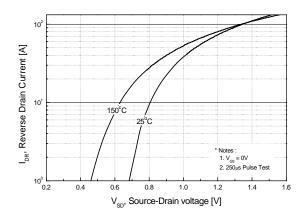
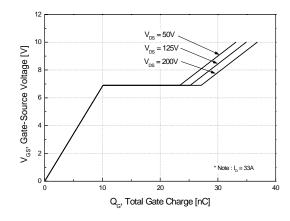


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

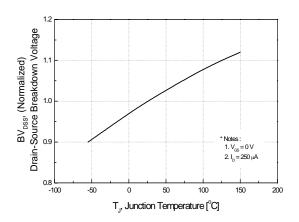


Figure 9-1. Maximum Safe Operating Area for FDP33N25

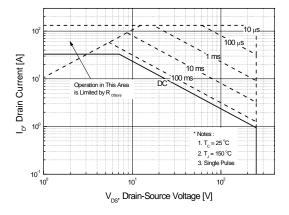


Figure 10. Maximum Drain Current vs. Case Temperature

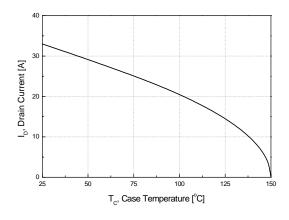


Figure 8. On-Resistance Variation vs. Temperature

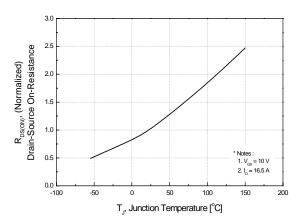
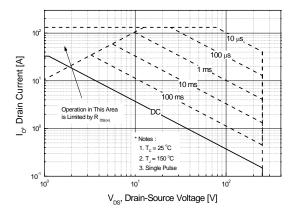


Figure 9-2. Maximum Safe Operating Area for FDPF33N25T



Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve for FDP33N25

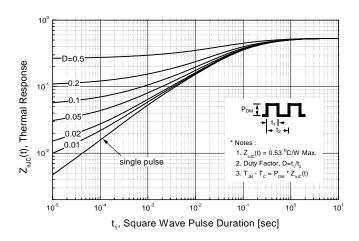
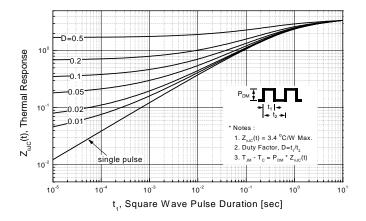
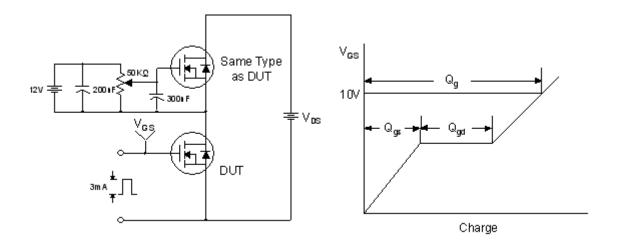


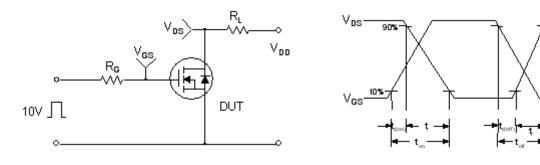
Figure 11-2. Transient Thermal Response Curve for FDPF33N25T



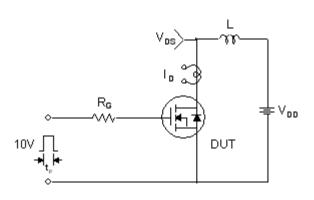
Gate Charge Test Circuit & Waveform

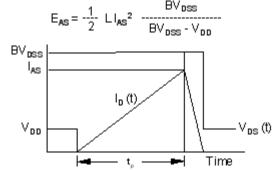


Resistive Switching Test Circuit & Waveforms

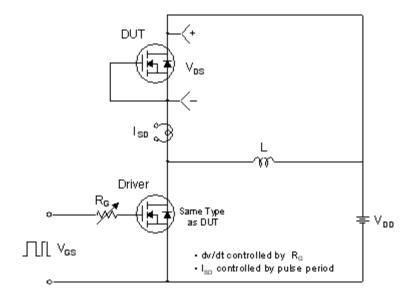


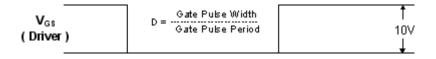
Unclamped Inductive Switching Test Circuit & Waveforms

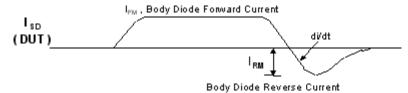


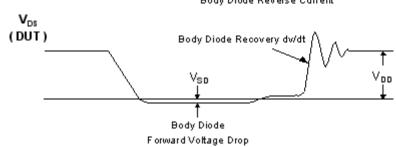


Peak Diode Recovery dv/dt Test Circuit & Waveforms



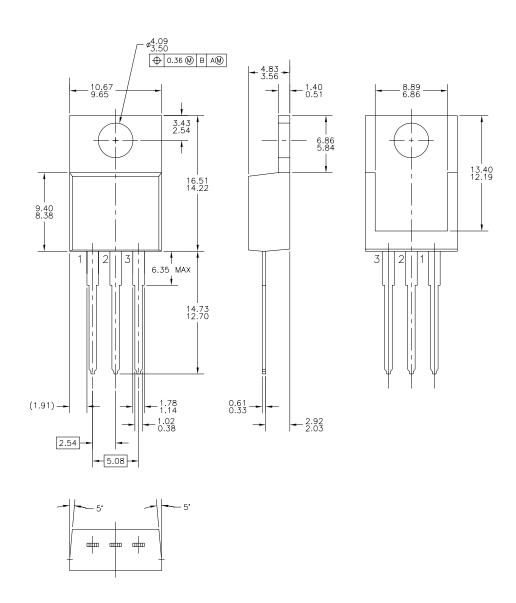






Mechanical Dimensions

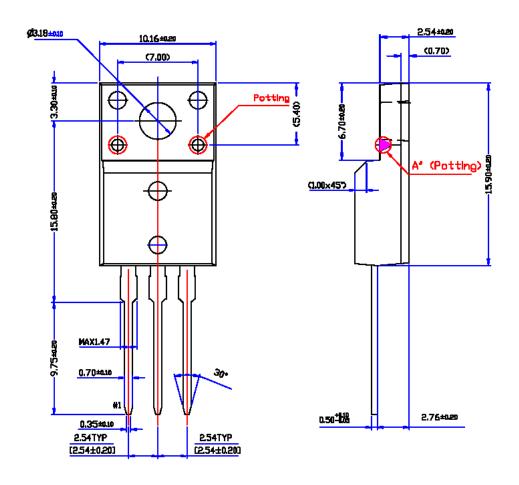
TO-220

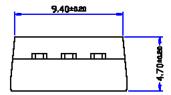


Dimensions in Millimeters

Package Dimensions

TO-220F Potted





* Front/Back Side Isolation Voltage : AC 2500V

Dimensions in Millimeters

Dimensions in Millimeters





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